Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/643,166	KIM ET AL.	
Examiner	Art Unit	
Linh T. Nguyen	2627	

	SEARCHED		
Class	Subclass	Date	Examiner
		-	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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DATE	
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